Table of Contents

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Research Articles

1 Measurement Analysis of Ultra-Wideband Monopole Antenna With Defected Ground Structure

Madan Kumar Sharma, Rajasthan Technical University Kota, Rajasthan, India Mithilesh Kumar, Rajasthan Technical University Kota, Rajasthan, India J.P. Saini, N.S.I.T., Delhi, India

13 Study of Wavelength-Dependent Bend Loss in Step-Index Multimode Fiber-Optic Microbend Displacement Sensor

Sami D. Alaruri, Independent Scholar, Mill Creek, USA

22 Novel Adaptive Exon Predictor for DNA Analysis Using Singular Value Decomposition

Srinivasareddy Putluri, Department of Electronics and Communication Engineering, Koneru Lakshmaiah Education Foundation, Guntur, India

Shaik Yasmin Fathima, Department of Electronics and Communication Engineering, Koneru Lakshmaiah Education Foundation, Guntur, India

Open Access Article

33 Full Field Imaging Ellipsometry (FFIE) Platform Using CCD Camera and Advanced Software for Simultaneous Spots' Sensing and Measurement

Avi Karsenty, Lev Academic Center, Faculty of Engineering, Department of Applied Physics/Electro-Optics Engineering, Jerusalem, Israel

Shmuel Feldman, Lev Academic Center, Faculty of Engineering, Department of Applied Physics/Electro-Optics Engineering, Jerusalem, Israel

Zvi Veig, Lev Academic Center, Faculty of Engineering, Department of Applied Physics/Electro-Optics Engineering, Jerusalem, Israel

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